74ABT16240A

$\frac{ \text{16-bit inverting buffer/line driver; 3-state}}{\text{Rev. 6} - 3 \text{ November 2011}}$

Product data sheet

General description 1.

The 74ABT16240A high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT16240A is an inverting 16-bit buffer that is ideal for driving bus lines. The device features four output enable inputs (10E, 20E, 30E, 40E), each controlling four of the 3-state outputs.

Features and benefits 2.

- 16-bit bus interface
- Multiple V_{CC} and GND pins minimize switching noise
- Power-up 3-state
- 3-state buffers
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- Output capability: +64 mA and -32 mA
- Live insertion and extraction permitted
- Latch-up protection exceeds 500 mA per JESD78 class II level A
- ESD protection:
 - ◆ HBM JESD-A114E exceeds 2000 V
 - CDM JESD22-C101-C exceeds 1000 V

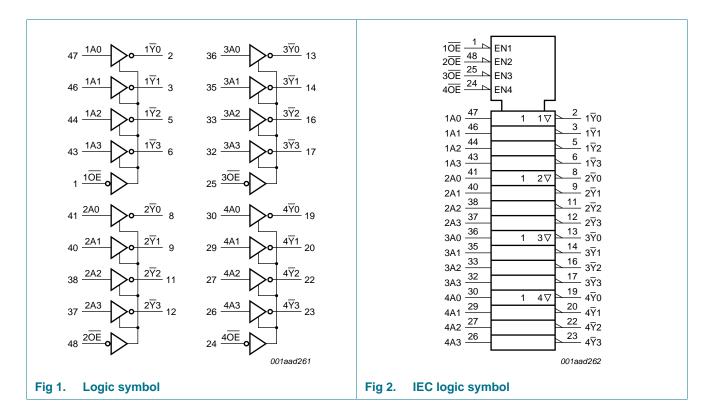
Ordering information 3.

Table 1. **Ordering information**

Type number	Package	Package									
	Temperature range	Name	Description	Version							
74ABT16240ADGG	–40 °C to +85 °C	TSSOP48	plastic thin shrink small outline package; 48 leads; body width 6.1 mm	SOT362-1							
74ABT16240ADL	–40 °C to +85 °C	SSOP48	plastic shrink small outline package; 48 leads; body width 7.5 mm	SOT370-1							

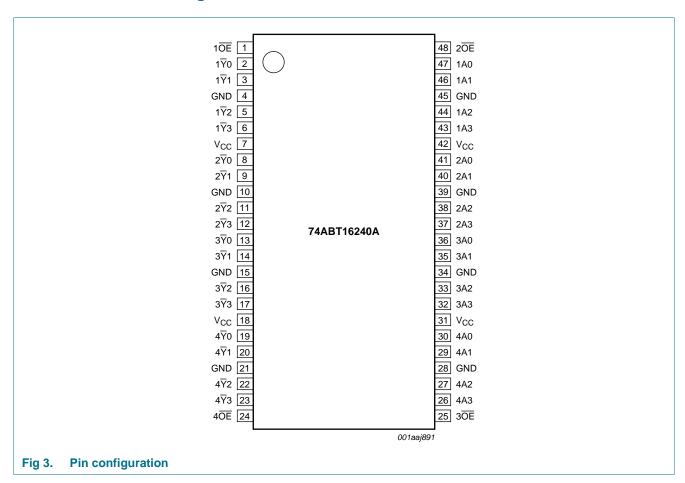


4. Functional diagram



5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
$1\overline{OE}$, $2\overline{OE}$, $3\overline{OE}$, $4\overline{OE}$	1, 48, 25, 24	output enable (LOW active)
$1\overline{Y}0, 1\overline{Y}1, 1\overline{Y}2, 1\overline{Y}3$	2, 3, 5, 6	1 data output
GND	4, 10, 15, 21, 28, 34, 39, 45	ground (0 V)
V _{CC}	7, 18, 31, 42	supply voltage
$2\overline{Y}0, 2\overline{Y}1, 2\overline{Y}2, 2\overline{Y}3$	8, 9, 11, 12	2 data output
$3\overline{Y}0, 3\overline{Y}1, 3\overline{Y}2, 3\overline{Y}3$	13, 14, 16, 17	3 data output
$4\overline{Y}0, 4\overline{Y}1, 4\overline{Y}2, 4\overline{Y}3$	19, 20, 22, 23	4 data output
4A0, 4A1, 4A2, 4A3	30, 29, 27, 26	4 data input
3A0, 3A1, 3A2, 3A3	36, 35, 33, 32	3 data input
2A0, 2A1, 2A2, 2A3	41, 40, 38, 37	2 data input
1A0, 1A1, 1A2, 1A3	47, 46, 44, 43	1 data input

6. Functional description

Table 3. Function table[1]

Control	Input	Output
nOE	nAn	nYn
L	L	Н
L	Н	L
Н	X	Z

^[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+7.0	V
VI	input voltage		<u>[1]</u> –1.2	+7.0	V
Vo	output voltage	output in OFF-state or HIGH-state	<u>[1]</u> –0.5	+5.5	V
I _{IK}	input clamping current	V _I < 0 V	-18	-	mΑ
I _{OK}	output clamping current	V _O < 0 V	-50	-	mΑ
Io	output current	output in LOW-state	-	128	mΑ
		output in HIGH-state	-	-64	mΑ
Tj	junction temperature		<u>[2]</u> _	150	°C
T _{stg}	storage temperature		-65	+150	°C

^[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

8. Recommended operating conditions

Table 5. Operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CC}	supply voltage		4.5	-	5.5	V
V_{I}	input voltage		0	-	V_{CC}	V
V_{IH}	HIGH-level input voltage		2.0	-	-	V
V_{IL}	LOW-level Input voltage		-	-	0.8	V
I _{OH}	HIGH-level output current		-32	-	-	mA
I_{OL}	LOW-level output current		-	-	32	mA
		duty cycle \leq 50 %; $f_i \geq$ 1 kHz	-	-	64	mA
$\Delta t/\Delta V$	input transition rise and fall rate		-	-	10	ns/V
T _{amb}	ambient temperature	in free air	-40	-	+85	°C

^[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

9. Static characteristics

Table 6. Static characteristics

Symbol	Parameter	Conditions			25 °C		-40 °C t	o +85 °C	Unit
				Min	Тур	Max	Min	Max	
V _{IK}	input clamping voltage	$V_{CC} = 4.5 \text{ V}; I_{IK} = -18 \text{ mA}$		-1.2	-0.9	-	-1.2	-	V
V _{OH}	HIGH-level output	$V_I = V_{IL}$ or V_{IH}							
	voltage	$V_{CC} = 4.5 \text{ V}; I_{OH} = -3 \text{ mA}$		2.5	2.9	-	2.5	-	V
		$V_{CC} = 5.0 \text{ V}; I_{OH} = -3 \text{ mA}$		3.0	3.4	-	3.0	-	V
		$V_{CC} = 4.5 \text{ V}; I_{OH} = -32 \text{ mA}$		2.0	2.4	-	2.0	-	V
V _{OL}	LOW-level output voltage	V_{CC} = 4.5 V; I_{OL} = 64 mA; V_{I} = V_{IL} or V_{IH}		-	0.42	0.55	-	0.55	V
l _l	input leakage current	V_{CC} = 5.5 V; V_I = V_{CC} or GND		-	±0.01	±1.0	-	±1.0	μΑ
I _{OFF}	power-off leakage current	V_{CC} = 0 V; V_{I} or $V_{O} \le 4.5$ V		-	±5.0	±100	-	±100	μΑ
I _{O(pu/pd)}	power-up/power-down output current	$V_{CC} = 2.0 \text{ V}; V_O = 0.5 \text{ V};$ $V_I = \text{GND or } V_{CC}; n\overline{\text{OE}} = \text{HIGH}$	[1]	-	±5.0	±50	-	±50	μΑ
l _{OZ}	OFF-state output	V_{CC} = 5.5 V; V_I = V_{IL} or V_{IH}							
	current	output HIGH-state at V _O = 5.5 V		-	1.0	10	-	10	μΑ
		output LOW-state at $V_O = 0.5 \text{ V}$		-	-1.0	-10	-	-10	μΑ
I _{LO}	output leakage current	HIGH-state; $V_O = 5.5 \text{ V}$; $V_{CC} = 5.5 \text{ V}$; $V_I = \text{GND or } V_{CC}$		-	1.0	50	-	50	μΑ
Io	output current	$V_{CC} = 5.5 \text{ V}; V_{O} = 2.5 \text{ V}$	[2]	-180	-70	-50	-180	-50	mΑ
I _{CC}	supply current	V_{CC} = 5.5 V; V_I = GND or V_{CC}							
		outputs HIGH-state		-	0.5	1.0	-	1.0	mΑ
		outputs LOW-state		-	8	19	-	19	mΑ
		outputs 3-state		-	0.5	1.0	-	1.0	mΑ
Δl _{CC}	additional supply current	per input pin; V_{CC} = 5.5 V; one input at 3.4 V and other inputs at V_{CC} or GND	[3][4]	-	10	200	-	200	μΑ
Cı	input capacitance	$V_I = 0 \text{ V or } V_{CC}$		-	4	-	-	-	pF
C _{I/O}	input/output capacitance	outputs disabled; $V_O = 0 V \text{ or } V_{CC}$		-	6	-	-	-	pF

^[1] This parameter is valid for any V_{CC} between 0 V and 2.1 V, with a transition time of up to 10 ms. From V_{CC} = 2.1 V to V_{CC} = 5 V \pm 10 %, a transition time of up to 100 μ s is permitted.

^[2] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

^[3] This is the increase in supply current for each input at 3.4 V.

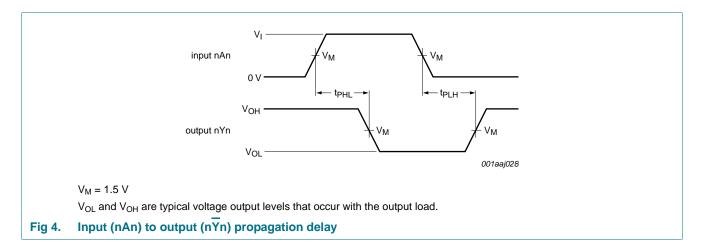
^[4] This data sheet limit may vary among suppliers.

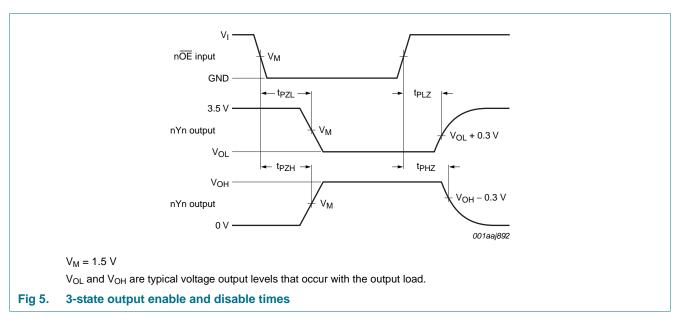
10. Dynamic characteristics

Table 7. Dynamic characteristics GND = 0 V. For test circuit, see Figure 6.

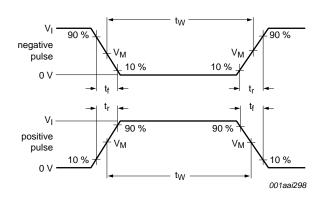
Symbol	Parameter	Conditions	25 °C	; V _{CC} =	5.0 V	-40 °C to	Unit	
			Min	Тур	Max	Min	Max	
t _{PLH}	LOW to HIGH propagation delay	nAn to $n\overline{Y}$ n, see Figure 4	1.0	2.0	3.0	1.0	3.7	ns
t _{PHL}	HIGH to LOW propagation delay	nAn to $n\overline{Y}$ n, see Figure 4	1.0	1.5	3.0	1.0	3.5	ns
t _{PZH}	OFF-state to HIGH propagation delay	nOE to nYn; see Figure 5	1.2	2.4	3.3	1.2	4.2	ns
t _{PZL}	OFF-state to LOW propagation delay	nOE to nYn; see Figure 5	1.2	2.3	3.2	1.0	4.2	ns
t _{PHZ}	HIGH to OFF-state propagation delay	nOE to nYn; see Figure 5	1.3	2.7	4.1	1.6	4.7	ns
t _{PLZ}	LOW to OFF-state propagation delay	nOE to nYn; see Figure 5	1.3	2.5	3.6	1.4	4.1	ns

11. Waveforms



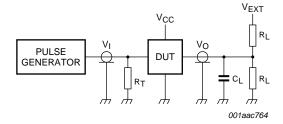


12. Test information



 $V_{M} = 1.5 V$

a. Input pulse definition



Test data is given in Table 8.

Definitions test circuit:

 R_L = Load resistance.

 C_L = Load capacitance including jig and probe capacitance.

 R_{T} = Termination resistance should be equal to output impedance Z_{0} of the pulse generator.

b. Test circuit for 3-state outputs

Fig 6. Load circuitry for switching times

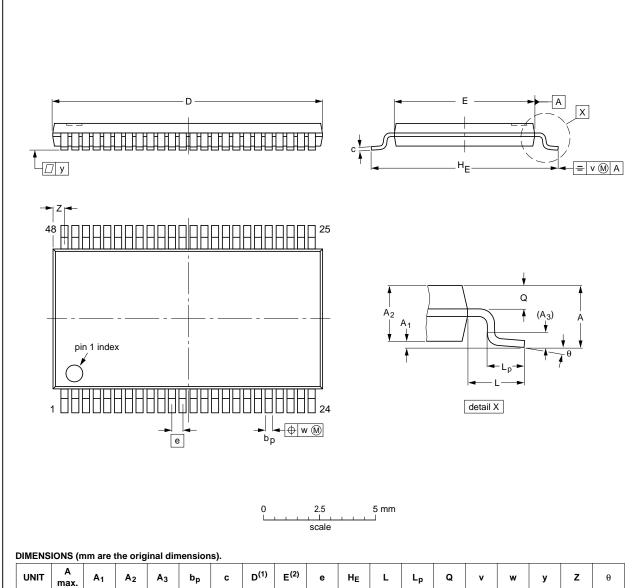
Table 8. Test data

Input				Load		V _{EXT}			
V_{I}	f _i t _W t _r			CL	R_L	t _{PHZ} , t _{PZH}	t _{PLH} , t _{PHL}		
3.0 V	1 MHz	500 ns	2.5 ns	50 pF	500Ω	open	7.0 V	open	

13. Package outline

TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1 mm

SOT362-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	e	HE	L	Lp	Q	v	w	у	Z	θ
mm	1.2	0.15 0.05	1.05 0.85	0.25	0.28 0.17	0.2 0.1	12.6 12.4	6.2 6.0	0.5	8.3 7.9	1	0.8 0.4	0.50 0.35	0.25	0.08	0.1	0.8 0.4	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER		EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT362-1		MO-153				99-12-27 03-02-19
		•		•		

Fig 7. Package outline SOT362-1 (TSSOP48)

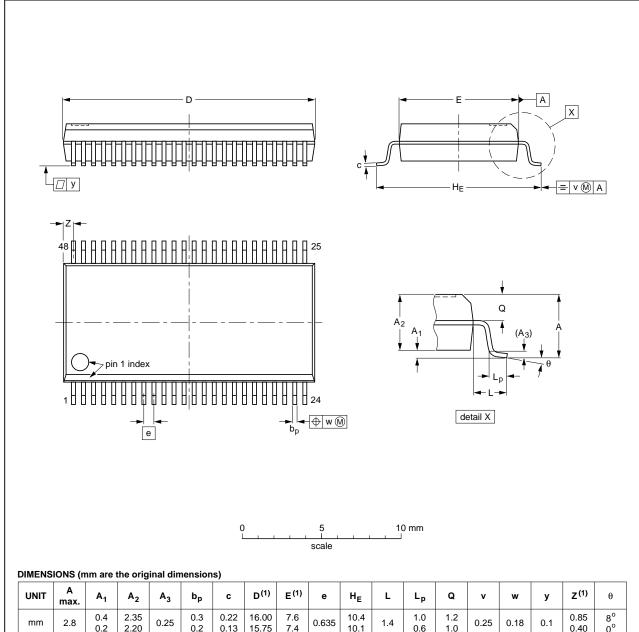
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SSOP48: plastic shrink small outline package; 48 leads; body width 7.5 mm

SOT370-1



-	····-·································																		
	UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
	mm	2.8	0.4 0.2	2.35 2.20	0.25	0.3 0.2	0.22 0.13	16.00 15.75	7.6 7.4	0.635	10.4 10.1	1.4	1.0 0.6	1.2 1.0	0.25	0.18	0.1	0.85 0.40	8° 0°

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	1330E DATE
SOT370-1		MO-118			99-12-27 03-02-19

Package outline SOT370-1 (SSOP48) Fig 8.

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14. Abbreviations

Table 9. Abbreviations

Acronym	Description
BiCMOS	Bipolar CMOS
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
CDM	Charged Device Model
TTL	Transistor-Transistor Logic

15. Revision history

Table 10. Revision history

	•			
Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT16240A v.6	20111103	Product data sheet	-	74ABT16240A v.5
Modifications:	 Legal pages 	updated		
74ABT16240A v.5	20100525	Product data sheet	-	74ABT16240A v.4
74ABT16240A v.4	20090325	Product data sheet	-	74ABT16240A v.3
74ABT16240A v.3	20040212	Product specification	01-A15420	74ABT_H16240A v.2
74ABT_H16240A v.2	19980225	Product specification	853-1880 19019	74ABT_H16240A
74ABT_H16240A	19961001	Product specification	-	-

16. Legal information

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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NXP Semiconductors 74ABT16240A

16-bit inverting buffer/line driver; 3-state

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18. Contents

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